Docket No. 130894-2

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:

D'Evelyn, et al.

Serial Number:

10/699,504

Filed:

10/31/2003

Examiner:

To be assigned

Art Unit:

1765

For:

HIGH PRESSURE/HIGH TEMPERATURE APPARATUS WITH IMPROVED

TEMPERATURE CONTROL FOR CRYSTAL GROWTH

Mail Stop Non-Fee Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Sir:

Enclosed is a copy of the Search Report in a corresponding foreign patent application, a copy of the cited references and Form PTO-1449. Please make these of record in the above-referenced application.

There references are relevant because they were cited during the prosecution of a counterpart foreign application.

If any fee is required, this is a request therefore for the Commissioner to charge Deposit Account No. 50-2339 (General Electric Company)

GE Advanced Materials One Plastics Avenue Pittsfield, MA 01201 August 12, 2004 Hanh T. Pham Attorney of Record Registration No. 40,771

Telephone No.: (413) 448-4664

CERTIFICATE OF MAILING (37 CFR 1.8a)

I hereby certify that this paper (along with any paper referred to as being attached or enclosed) is being deposited with the United States Postal Service on the date shown below with sufficient postage as First Class mail in an envelope addressed to the: Commissioner of Patents and Trademarks, Alexandria, VA 22313-1450, Mail Stop Non-Fee Amendment.

Date: August 12, 2004

Judith & Rowe

AUG 1 6 2004

Form PTO-1449 ed)
INFORMATION DISCLOSURE CITATION INAME (Reproduced)

IN AN APPLICATION

(Use several sheets if necessary)

Docket Number (Optional)	Appl
130894-2	

lication Number 10/699504

1765

Applicant

GENERAL ELECTRIC COMPANY

Filing Date Group Art Unit 10/31/2003

		U.	S. PATENT DOCUMENTS				
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS		G DATE
	US2003/140845	07/31/03	D'Evelyn et al.		_	Zurko	I KUYI.
					-		
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		FORE	IGN PATENT DOCUMENTS				
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-	TRANSI	LATION
					CLASS	YES	NO
	EP0220462	05/06/87	Europe				
	EP0157393	10/09/85	Europe .				
	GB922619	04/03/63	Great Britian				
	FR1306951	10/19/62	France				
	WO 01/36080	05/25/01	World				
	EP0152726	08/28/85	Europe				
	OTHER D	OCUMENTS (In	acluding Author, Title, Date, Per	rtinent Pages,	Etc.)		
	Hanser A D, e structures of A	t al: "Growth, de AlN, GaN, and A	oping and characterization of ep lxGal-xN"; XP004364890	itaxial thin filr	ns and patte	erened	
			"Polarization dependent x-ray aN grown at different condition			chemical	Ī
EXAMINEI	<u> </u>		DATE CONSIDER	RED			

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.